

# MOSFET – Power, Single N-Channel, Logic Level, DUAL COOL<sup>®</sup> DFN8 5x6 40 V, 0.7 mΩ, 349 A

# Product Preview

# NTMFSC0D7N04XL

#### **Features**

- Low R<sub>DS(on)</sub> to Minimize Conduction Loss
- Low Q<sub>RR</sub> with Soft Recovery to Minimize E<sub>RR</sub> Loss and Voltage Spike
- Low Q<sub>G</sub> and Capacitance to Minimize Driving and Switching Loss
- Advanced Dual-Sided Cooled Packaging
- These Devices are Pb–Free, Halogen Free/BFR Free and are RoHS Compliant

# **Typical Applications**

- High Switching Frequency DC-DC Conversion
- Synchronous Rectification

#### MAXIMUM RATINGS (T<sub>J</sub> = 25°C unless otherwise stated)

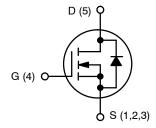
Parameter	Symbol	Value	Unit	
Drain-to-Source Voltage		$V_{DSS}$	40	V
Gate-to-Source Voltage	DC	V <sub>GS</sub>	±20	V
Continuous Drain Current	T <sub>C</sub> = 25°C	I <sub>D</sub>	349	Α
(Note 2)	T <sub>C</sub> = 100°C		247	
Power Dissipation (Note 2)	T <sub>C</sub> = 25°C	P <sub>D</sub>	167	W
	T <sub>C</sub> = 100°C		83	
Pulsed Drain Current	T <sub>C</sub> = 25°C,	I <sub>DM</sub>	1667	Α
Pulsed Source Current (Body Diode)	t <sub>p</sub> = 100 μs	I <sub>SM</sub>	1667	
Operating Junction and Storage Range	Temperature	T <sub>J</sub> , T <sub>STG</sub>	-55 to +175	°C
Source Current (Body Diode)	I <sub>S</sub>	256	Α	
Single Pulse Avalanche Energy (I <sub>PK</sub> = 97 A) (Note 3)		E <sub>AS</sub>	470	mJ
Lead Temperature for Soldering Purposes (1/8" from case for 10 s)		TL	260	°C

Stresses exceeding those listed in the Maximum Ratings table may damage the device. If any of these limits are exceeded, device functionality should not be assumed, damage may occur and reliability may be affected.

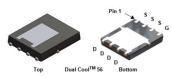
- 1. Surface-mounted on FR4 board using 1 in<sup>2</sup> pad size, 1 oz Cu pad.
- The entire application environment impacts the thermal resistance values shown, they are not constants and are only valid for the particular conditions noted.
- 3.  $E_{AS}$  of 470 mJ is based on started  $T_{J}=25^{\circ}C$ ,  $I_{AS}=97$  A,  $V_{DD}=32$  V,  $V_{GS}=10$  V, 100% avalanche tested.

This document contains information on a product under development. **onsemi** reserves the right to change or discontinue this product without notice.

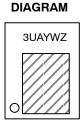
V <sub>(BR)DSS</sub>	R <sub>DS(ON)</sub> MAX	I <sub>D</sub> MAX
40 V	0.7 mΩ @ 10 V	349 A
40 V	1.1 mΩ @ 4.5 V	349 A



N-CHANNEL MOSFET



DFN8 5x6.15 CASE 506EG



**MARKING** 

3U = Specific Device Code A = Assembly Location

/ = Year

W = Work Week

Z = Assembly Lot Code

#### **ORDERING INFORMATION**

See detailed ordering, marking and shipping information on page 6 of this data sheet.

# THERMAL CHARACTERISTICS

Parameter	Symbol	Value	Unit
Thermal Resistance, Junction-to-Case, Bottom	$R_{ heta JC}$	0.9	°C/W
Thermal Resistance, Junction-to-Case, Top	$R_{ heta JT}$	1.4	°C/W
Thermal Resistance, Junction-to-Ambient	$R_{ heta JA}$	38	°C/W

# **ELECTRICAL CHARACTERISTICS** (T<sub>J</sub> = 25°C unless otherwise specified)

Parameter	Symbol	Test Conditions	Min	Тур	Max	Unit
OFF CHARACTERISTICS	•					
Drain-to-Source Breakdown Voltage	V <sub>(BR)DSS</sub>	$V_{GS} = 0 \text{ V}, I_D = 1 \text{ mA}$	40			V
Drain-to-Source Breakdown Voltage Temperature Coefficient	$\Delta V_{(BR)DSS}/ \Delta T_J$	I <sub>D</sub> = 1 mA, Referenced to 25°C		16.6		mV/°C
Zero Gate Voltage Drain Current	I <sub>DSS</sub>	V <sub>DS</sub> = 40 V, T <sub>J</sub> = 25°C			10	μΑ
		V <sub>DS</sub> = 40 V, T <sub>J</sub> = 125°C			100	)
Gate-to-Source Leakage Current	I <sub>GSS</sub>	V <sub>GS</sub> = 20 V, V <sub>DS</sub> = 0 V			100	nA
ON CHARACTERISTICS						
Drain-to-Source On Resistance	R <sub>DS(on)</sub>	V <sub>GS</sub> = 10 V, I <sub>D</sub> = 49 A		0.58	0.7	mΩ
		V <sub>GS</sub> = 6 V, I <sub>D</sub> = 49 A		0.66	0.9	
		V <sub>GS</sub> = 4.5 V, I <sub>D</sub> = 39 A		0.77	1.1	
Gate Threshold Voltage	V <sub>GS(TH)</sub>	$V_{GS} = V_{DS}, I_D = 250 \mu A$	1.3		2.2	V
Gate Threshold Voltage Temperature Coefficient	ΔV <sub>GS(TH)</sub> / ΔT <sub>J</sub>	$V_{GS} = V_{DS}$ , $I_D = 250 \mu A$		-5.35		mV/°C
Forward Transconductance	9FS	V <sub>DS</sub> = 5 V, I <sub>D</sub> = 49 A		245		S
CHARGES, CAPACITANCES & GATE RES	SISTANCE					
Input Capacitance	C <sub>ISS</sub>			7090		pF
Output Capacitance	C <sub>OSS</sub>	V <sub>GS</sub> = 0 V, V <sub>DS</sub> = 20 V, f = 1 MHz		1860		
Reverse Transfer Capacitance	C <sub>RSS</sub>			40		
Output Charge	Q <sub>OSS</sub>	V <sub>GS</sub> = 0 V, V <sub>DS</sub> = 20 V		72		nC
Total Gate Charge	Q <sub>G(TOT)</sub>	$V_{GS} = 4.5 \text{ V}, V_{DD} = 20 \text{ V}; I_D = 49 \text{ A}$		42		
		V <sub>GS</sub> = 6 V, V <sub>DD</sub> = 20 V; I <sub>D</sub> = 49 A		57		
		V <sub>GS</sub> = 10 V, V <sub>DD</sub> = 20 V; I <sub>D</sub> = 49 A		96		
Threshold Gate Charge	Q <sub>G(TH)</sub>			11		
Gate-to-Source Charge	$Q_{GS}$	V 40.V.V 00.V.I 40.A		20		1
Gate-to-Drain Charge	$Q_{GD}$	$V_{GS} = 10 \text{ V}, V_{DD} = 20 \text{ V}; I_D = 49 \text{ A}$		6		
Gate Plateau Voltage	V <sub>GP</sub>			2.89		V
Gate Resistance	$R_{G}$	f = 1 MHz		0.5		Ω
SWITCHING CHARACTERISTICS	-					
Turn-On Delay Time	t <sub>d(ON)</sub>			25		ns
Rise Time	t <sub>r</sub>	Resistive Load,		7		
Turn-Off Delay Time	t <sub>d(OFF)</sub>	$V_{GS} = 0/10 \text{ V}, V_{DD} = 20 \text{ V},$ $I_D = 49 \text{ A}, R_G = 2.5 \Omega$		64		
Fall Time	t <sub>f</sub>	<b>1</b>		5		1

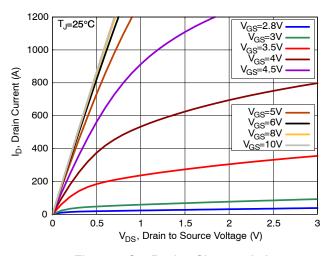
# **ELECTRICAL CHARACTERISTICS** ( $T_J = 25^{\circ}C$ unless otherwise specified)

Parameter	Symbol	Test Conditions	Min	Тур	Max	Unit
SOURCE-TO-DRAIN DIODE CHARACTERISTICS						
Forward Diode Voltage	$V_{SD}$	$V_{GS} = 0 \text{ V}, I_S = 49 \text{ A}, T_J = 25^{\circ}\text{C}$		0.8	1.2	V
		V <sub>GS</sub> = 0 V, I <sub>S</sub> = 49 A, T <sub>J</sub> = 125°C		0.65		
Reverse Recovery Time	t <sub>RR</sub>			39		ns
Charge Time	t <sub>a</sub>	V <sub>GS</sub> = 0 V, dI/dt = 300 A/μs,		21		
Discharge Time	t <sub>b</sub>	$V_{GS} = 0 \text{ V, dI/dt} = 300 \text{ A/}\mu\text{s,}$ $I_{S} = 49 \text{ A, V}_{DD} = 20 \text{ V}$		18		
Reverse Recovery Charge	$Q_{RR}$	1		87		nC

Product parametric performance is indicated in the Electrical Characteristics for the listed test conditions, unless otherwise noted. Product performance may not be indicated by the Electrical Characteristics if operated under different conditions.

#### **TYPICAL CHARACTERISTICS**

1200



1000 V<sub>DS</sub>=5V

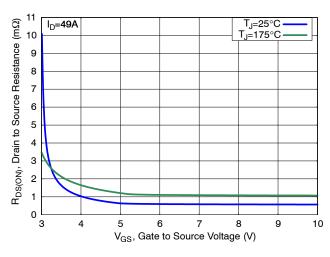
1000 V<sub>DS</sub>=5V

1000 600

200 T<sub>J</sub>=-55°C T<sub>J</sub>=175°C T<sub>J</sub>=175°C

Figure 1. On-Region Characteristics

Figure 2. Transfer Characteristics



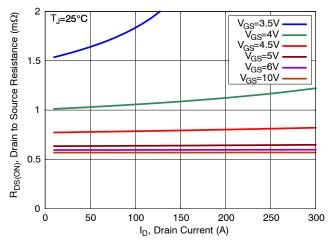
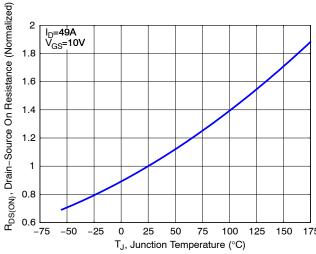


Figure 3. On-Resistance vs. Gate Voltage

Figure 4. On-Resistance vs. Drain Current



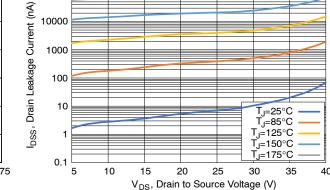


Figure 5. Normalized ON Resistance vs. Junction Temperature

Figure 6. Drain Leakage Current vs. Drain Voltage

1000000

100000

## TYPICAL CHARACTERISTICS (continued)

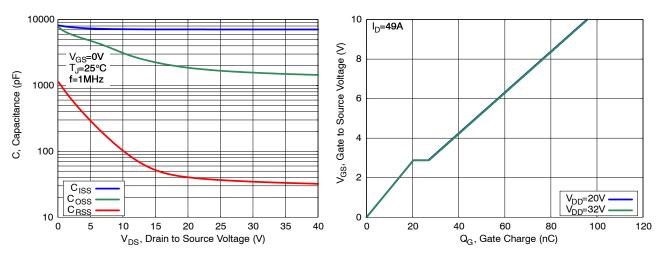


Figure 7. Capacitance Characteristics

Figure 8. Gate Charge Characteristics

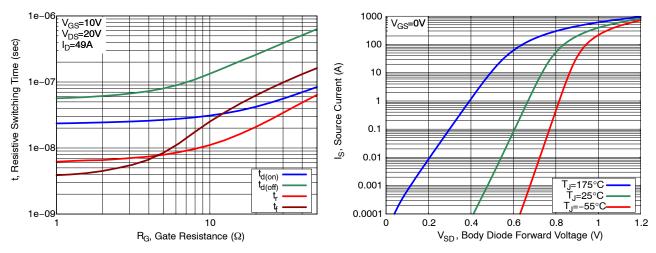


Figure 9. Resistive Switching Time Variation vs. Gate Resistance

Figure 10. Diode Forward Characteristics

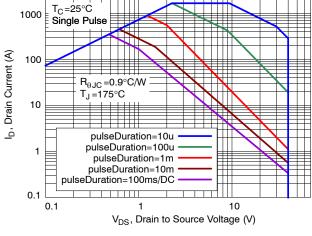


Figure 11. Safe Operating Area (SOA)

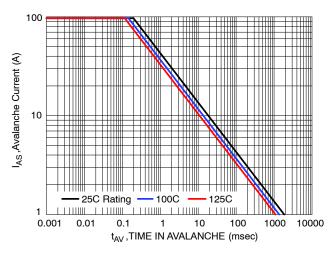


Figure 12. Avalanche Current vs. Pulse Time (UIS)

# TYPICAL CHARACTERISTICS (continued)

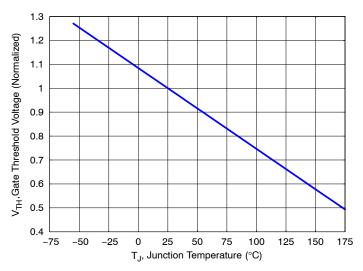


Figure 13. Gate Threshold Voltage vs. Junction Temperature

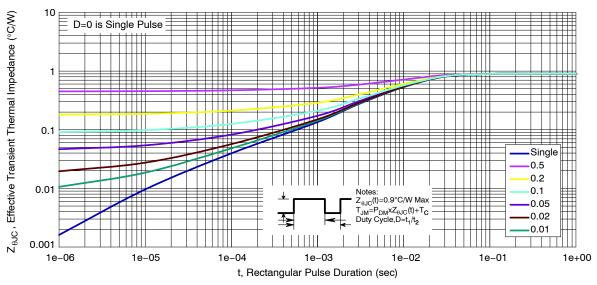


Figure 14. Thermal Characteristics

#### **DEVICE ORDERING INFORMATION**

Device	Marking	Package	Shipping <sup>†</sup>
NTMFSC0D7N04XLTWG	3U	DFN8 5x6 (Pb–Free/Halogen Free)	3000 / Tape & Reel

<sup>†</sup>For information on tape and reel specifications, including part orientation and tape sizes, please refer to our Tape and Reel Packaging Specifications Brochure, BRD8011/D.

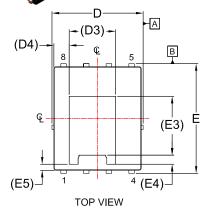
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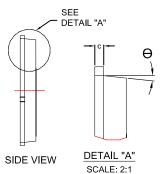


# DFN8 5x6.15, 1.27P, DUAL COOL

CASE 506EG ISSUE D

**DATE 25 AUG 2020** 

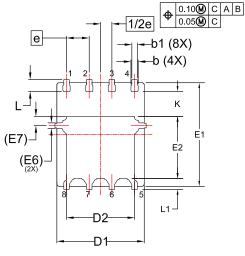


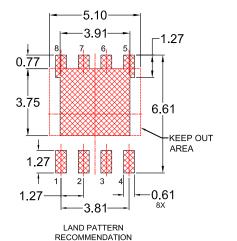


#### NOTES:

- 1. DIMENSIONING AND TOLERANCING PER ASME Y14.5M, 2009.
- 2. CONTROLLING DIMENSION: MILLIMETERS
- 3. COPLANARITY APPLIES TO THE EXPOSED PADS AS WELL AS THE TERMINALS.
- 4. DIMENSIONS D1 AND E1 DO NOT INCLUDE MOLD FLASH, PROTRUSIONS, OR GATE BURRS.
- 5. SEATING PLANE IS DEFINED BY THE TERMINALS. "A1" IS DEFINED AS THE DISTANCE FROM THE SEATING PLANE TO THE LOWEST POINT ON THE PACKAGE BODY.

FRONT VIEW SEE DETAIL "B"		A2	Θ A1	SEATING PLANE
		DETAIL "B"		
0.10 <b>M</b>	CAB	SCALE: 2:1		



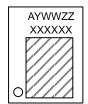


\*FOR ADDITIONAL INFORMATION ON OUR PB-FREE STRATEGY AND SOLDERING DETAILS, PLEASE DOWNLOAD THE ON SEMICONDUCTOR SOLDERING AND MOUNTING TECHNIQUES REFERENCE MANUAL, SOLDERRM/D.

DIM	MILLIMETERS			
	MIN.	NOM.	MAX.	
Α	0.85	0.90	0.95	
A1	-	-	0.05	
A2	-	-	0.05	
b	0.31	0.41	0.51	
b1	0.21	0.31	0.41	
С	0.20	0.25	0.30	
D	4.90	5.00	5.10	
D1	4.80	4.90	5.00	
D2	3.67	3.82	3.97	
D3	2.60 REF			
D4	0.86 REF			
Е	6.05	6.15	6.25	
E1	5.70	5.80	5.90	
E2	3.38	3.48	3.58	
E3	•	3.30 REF		
E4		0.50 REF	=	
E5	Û	0.34 REF	:	
E6	(	0.30 REF		
E7	-	0.52 REF	=	
е	1	1.27 BSC	;	
1/2e	0	.635 BS0	0	
K	1.30	1.40	1.50	
L	0.56	0.66	0.76	
L1	0.52	0.62	0.72	
Ф	0°		12°	

# GENERIC MARKING DIAGRAM\*

**BOTTOM VIEW** 



XXXX = Specific Device Code

A = Assembly Location

Y = Year

WW = Work Week

ZZ = Assembly Lot Code

\*This information is generic. Please refer to device data sheet for actual part marking. Pb-Free indicator, "G" or microdot "•", may or may not be present. Some products may not follow the Generic Marking.

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